## Notice of References Cited Application/Control No. 10/785,991 Examiner Steven J. Fulk Applicant(s)/Patent Under Reexamination YANG, SWEEHAN J.H. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,916,721	07-2005	Heineck et al.	438/389
	В	US-6,426,253	07-2002	Tews et al.	438/243
	O	US-2004/0229426	11-2004	Lee et al.	438/248
	۵	US-2004/0063321	04-2004	Goebel et al.	438/689
	ш	US-6,080,682	06-2000	lbok, Effiong E.	438/770
	F	US-5,330,920	07-1994	Soleimani et al.	438/703
	G	US-			
	Н	US-			
	- 1	US-			
	J	US-		·	
	К	US-			
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					·
	Р			,		
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	>						
	V						
	X						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.